

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,328	LEE ET AL.	
Examiner	Art Unit	
Kevin T. Truona	3734	

SEARCHED					
Class	Subclass	Date	Examiner		
606	159	575786	~		
	170				
	167				
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	180				
600	544				
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	564				
	567				
	562				
128	898				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	5) \$106	4	
fre. appl.	\$5706	W	
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